

<b>Notice of References Cited</b>	Application/Control No. 10/632,088	Applicant(s)/Patent Under Reexamination BAJKO ET AL.	
	Examiner Khai M. Nguyen	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,556,820 B1	04-2003	Le et al.	455/411
*	B	US-2005/0009520 A1	01-2005	Herrero et al.	455/435.1
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	D	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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